

General Features

• $V_{DS} = 100 \text{ V}, I_D = 0.17 \text{A}$

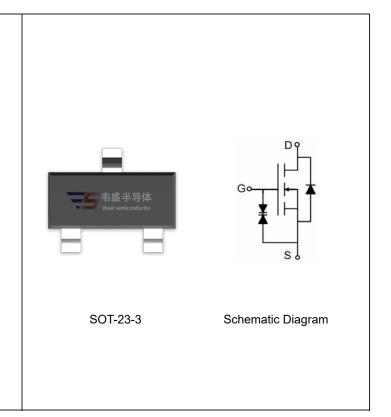
 $R_{DS(ON)} < 7.2\Omega$ @ $V_{GS}=10V$

 $R_{DS(ON)}$ < 8Ω @ V_{GS} =4.5V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package
- ESD 2KV HBM

Application

- Direct logic-level interface: TTL/CMOS
- Drivers: relays, solenoids, lamps, hammers, display, memories, transistors, etc.
- Battery operated systems
- Solid-state relays



Package Marking And Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSMBSS123K-S2	VSMBSS123K	SOT-23-3	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

5 \ 7.				
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage	Vgs	±20	V	
Continuous Proin Current /T =150°C)	T _A =25℃		0.17	^
Continuous Drain Current (T _J =150°C)	T _A =100°C	I _D	0.12	Α
Drain Current-Pulsed (Note 1) Maximum Power Dissipation		I _{DM}	0.68	Α
		P _D	0.35	W
Operating Junction and Storage Temperature	Range	T _J ,T _{STG}	-55 To 150	$^{\circ}$ C

Thermal Characteristic

Thermal Resistance,Junction-to-Ambient (Note 2)	R _{θJA}	350	°C/W
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Electrical Characteristics (T_A=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit			
Off Characteristics									
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	100	-	-	V			



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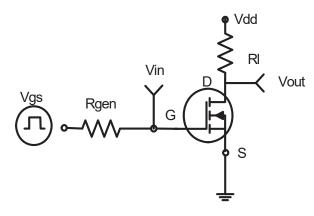
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =100V,V _{GS} =0V	-	-	1	μΑ
Cata Bady Laakaga Current	I _{GSS}	V _{GS} =±10V,V _{DS} =0V	-	-	±1	uA
Gate-Body Leakage Current		V _{GS} =±20V,V _{DS} =0V	-		±10	uA
On Characteristics (Note 3)			•	•		
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} ,I _D =250μA	1.0	1.3	1.9	V
Drain-Source On-State Resistance	В	V _{GS} =10V, I _D =0.17A	-	6.5	7.2	Ω
Dialit-Source Oit-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =0.17A	-	7	8	Ω
Forward Transconductance	G FS	V _{DS} =5V,I _D =0.17A	0.1	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C _{lss}	V 50VV 0V	-	29	50	PF
Output Capacitance	C _{oss}	V_{DS} =50V, V_{GS} =0V, F=1.0MHz	-	10	25	PF
Reverse Transfer Capacitance	C _{rss}	F-1.0WIFIZ	-	2	5	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	8	-	nS
Turn-on Rise Time	t _r	V _{DD} =50V,I _D =0.17A	-	8	-	nS
Turn-Off Delay Time	t _{d(off)}	V_{GS} =10 V , R_{GEN} =10 Ω	-	13	-	nS
Turn-Off Fall Time	t _f		-	16	-	nS
Total Gate Charge	Qg	V _{DS} =50V,I _D =0.17A, V _{GS} =10V	-	1.7	3	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{SD}	V _{GS} =0V,I _S =0.17A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	-	0.17	Α

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- **4.** Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics



V_{OUT}

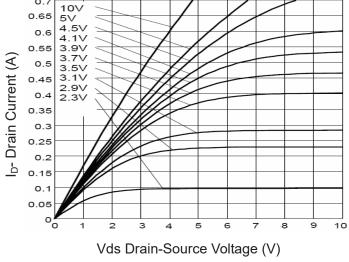
V_{IN}

10%

PULSE WIDTH

Figure 1:Switching Test Circuit

Figure 2:Switching Waveforms



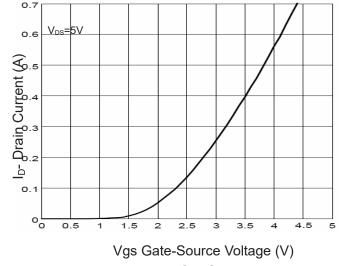
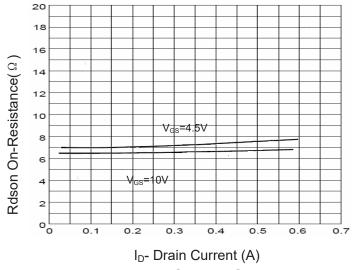


Figure 3 Output Characteristics

Figure 4 Transfer Characteristics



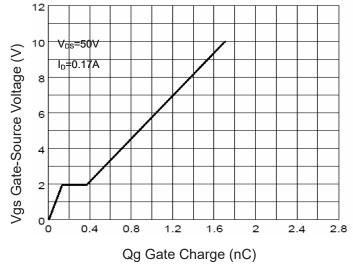


Figure 5 Drain-Source On-Resistance

Figure 6 Gate Charge



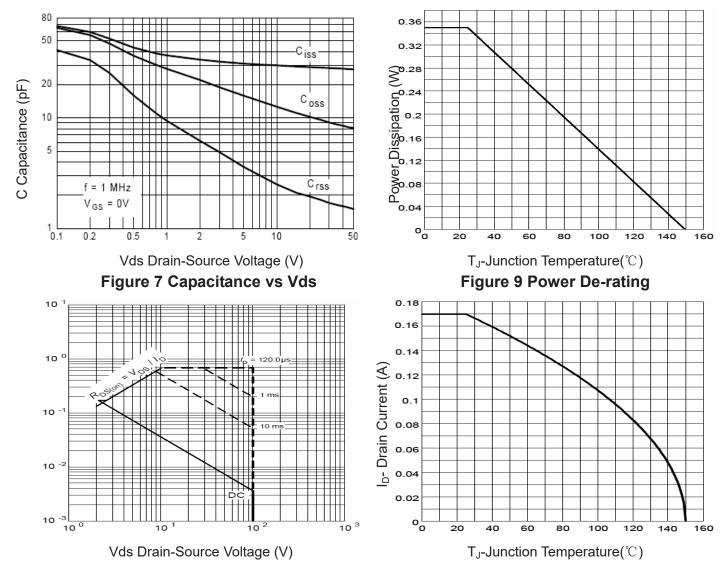


Figure 8 Safe Operation Area

Figure 10 Current De-rating

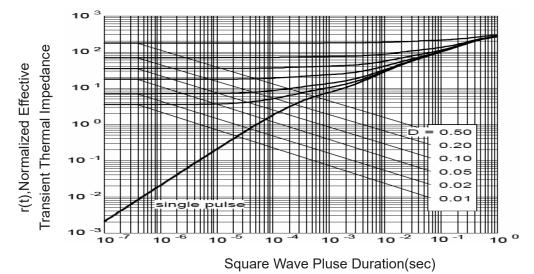


Figure 11 Normalized Maximum Transient Thermal Impedance